Power MOSFET

40 V, Dual N-Channel, SOIC-8

Features

- Asymmetrical N Channels
- Low R_{DS(on)}
- Low Capacitance
- Optimized Gate Charge
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

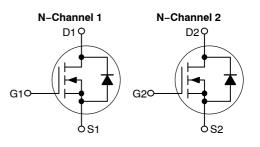
	V _{(BR)DSS}	R _{DS(on)} Max	I _D Max (Notes 1 and 2)
Channel 1	40 V	12 mΩ @ 10 V	11 A
		16 mΩ @ 4.5 V	
Channel 2	40 V	25 mΩ @ 10 V	6.5 A
		30.8 mΩ @ 4.5 V	

- 1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
- 2. Only selected channel is been powered 1W applied on channel 1: T_J = 1 W * 85°C/W + 25°C = 110°C

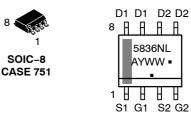


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MARKING DIAGRAM* AND PIN ASSIGNMENT



A = Assembly Location Y = Year

WW = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Package	Shipping [†]
SOIC-8 (Pb-Free)	2500 / Tape & Reel
	SOIC-8

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Ch 1	Ch 2	Unit		
Drain-to-Source Voltage	V _{DSS}	40	40	V		
Gate-to-Source Voltage			V _{GS}	±20	±20	V
Continuous Drain Current $R_{\theta JA}$ (Notes 3 and 4)	Steady	$T_A = 25^{\circ}C$	۱ _D	9.0	5.7	Α
	State	$T_A = 70^{\circ}C$		7.2	4.6	
Power Dissipation $R_{\theta JA}$ (Notes 3 and 4)	1 4) T _A = 25°C		PD	1.5	1.5	W
		$T_A = 70^{\circ}C$		0.9	0.9	
Continuous Drain Current $R_{\theta JA}$ (Notes 3 and 4)	$t \le 10s$	$T_A = 25^{\circ}C$	۱ _D	11	6.5	Α
		$T_A = 70^{\circ}C$		8.6	4.6	
Power Dissipation $R_{\theta JA}$ (Notes 3 and 4)		$T_A = 25^{\circ}C$	PD	2.1	1.9	W
		$T_A = 70^{\circ}C$		1.3	1.2	
Pulsed Drain Current	t _p = 10 μs	5	I _{DM}	43	26	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to	o +150	°C
Source Current (Body Diode)	۱ _S	10	7.0	Α		
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} =	E _{AS}	76	22	mJ		
			I _{AS}	39	21	Α
Lead Temperature for Soldering Purposes (1/8" from case for 10s)				2	60	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

3. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)

4. Only selected channel is been powered 1W applied on channel 1: $T_J = 1 W * 85^{\circ}C/W + 25^{\circ}C = 110^{\circ}C$

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Ch 1	Ch 2	Unit
Junction-to-Ambient Steady State (Notes 5 and 7)	R _{0JA}	85	86	°C/W
Junction–to–Ambient – t \leq 10 s (Notes 5 and 7)	$R_{\theta JA}$	60		
Junction-to-Ambient Steady State (Notes 5 and 8)	$R_{\theta JA}$	59		
Junction-to-Ambient Steady State (Notes 6 and 7)	R _{θJA}	136	136	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces)
Surface-mounted on FR4 board using 0.155 in sq (100 mm²) pad size

7. Only selected channel is been powered

1W applied on channel 1: $T_J = 1 W * 85^{\circ}C/W + 25^{\circ}C = 110^{\circ}C$ 8. Both channels receive equivalent power dissipation

1 W applied on each channel: $T_1 = 2 W * 59^{\circ}C/W + 25^{\circ}C = 143^{\circ}C$

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Ch	Min	Тур	Max	Unit
OFF CHARACTERISTICS								
Drain-to-Source Breakdown	V _{(BR)DSS}		050	Ch 1	40			V
Voltage		V _{GS} = 0 V, I	D = 250 μΑ	Ch 2				
Drain-to-Source Breakdown	V _{(BR)DSS}			Ch 1		146		mV/ °C
Voltage Temperature Coefficient	/ T _J			Ch 2		25		÷C
Zero Gate Voltage Drain Current	I _{DSS}		T,∣ = 25°C	Ch 1			1.0	μA
		V _{GS} = 0 V,	1j = 25 0	Ch 2				
		$V_{DS} = 40 V$	$V_{GS} = 0 V,$ $V_{DS} = 40 V$				100	
			T _J = 125°C	Ch 2				
Gate-to-Source Leakage Current	I _{GSS}						±100	nA
		V _{DS} = 0 V, V ₀	$GS = \pm 20 V$	Ch 2				

ON CHARACTERISTICS (Note 9)

Gate Threshold Voltage	V _{GS(TH)}		Ch 1	1.0	1.8	3.0	V
		VGS = VDS, I_D = 250 μ A	Ch 2	1.0	1.8	3.0	
Negative Threshold Temperature Coefficient	V _{GS(TH)} / TJ		Ch 1		6.0		mV/°C
Coefficient	IJ		Ch 2		6.0		
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 10 V, I _D = 10 A	Ch 1		9.5	12	mΩ
		V_{GS} = 10 V, I_{D} = 7 A	Ch 2		20.5	25	
		V_{GS} = 4.5 V, I _D = 10 A	Ch 1		13	16	mΩ
		V_{GS} = 4.5 V, I _D = 7 A	Ch 2		25.0	30.8	
Forward Transconductance	9 _{FS}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 10 \text{ A}$	Ch 1		10.5		S
		V_{DS} = 15 V, I _D = 7 A	Ch 2		6.0		

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C _{ISS}		Ch 1	2120	pF
			Ch 2	730	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} =	Ch 1	315	
		20 V	Ch 2	123	
Reverse Transfer Capacitance	C _{RSS}		Ch 1	225	
			Ch 2	84	

9. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%

10. Switching characteristics are independent of operating junction temperatures

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition	Ch	Min	Тур	Max	Unit				
CHARGES, CAPACITANCES & GATE RESISTANCE											
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10V, V_{DS} = 20V, I_{D} = 10A	Ch 1		36	50	nC				
		V_{GS} = 10 V, V_{DS} = 20 V, I_{D} = 7 A	Ch 2		16						
			Ch 1		15	23					
			Ch 2		8.5	11					
Threshold Gate Charge	Q _{G(TH)}		Ch 1		2.4						
			Ch 2		1.0						
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 20 V, CH1:	Ch 1		6.9						
			Ch 2		2.8						
Gate-to-Drain Charge	Q _{GD}		Ch 1		7.2						
			Ch 2		4.0						
Plateau Voltage	V _{GP}		Ch 1		3.2		V				
			Ch 2		3.3						
Gate Resistance	R _G		Ch 1		1.2		Ω				
			Ch 2		2.1						

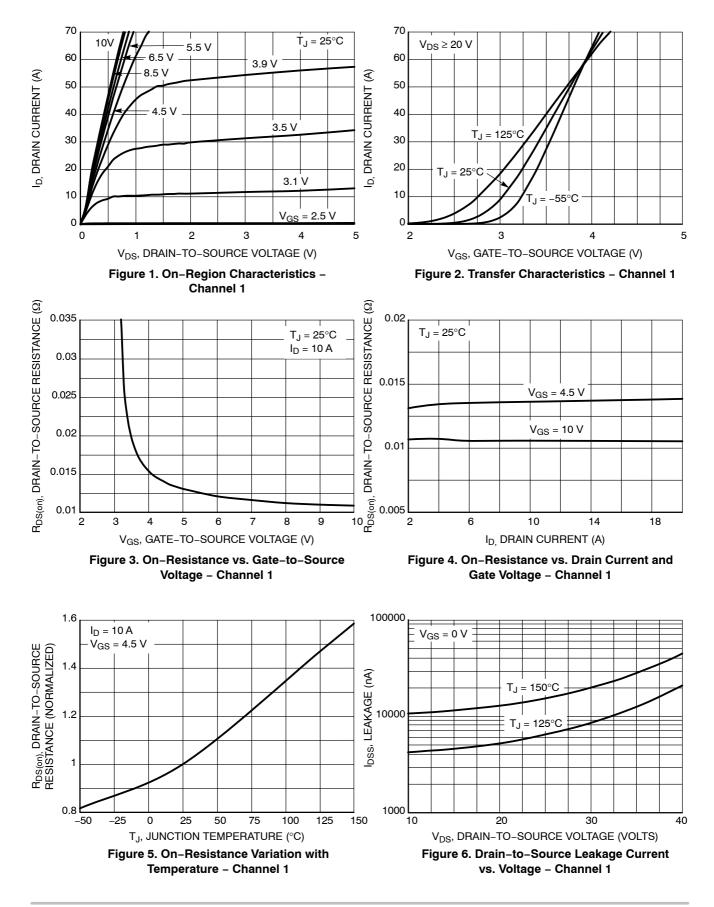
SWITCHING CHARACTERISTICS (Note 10)

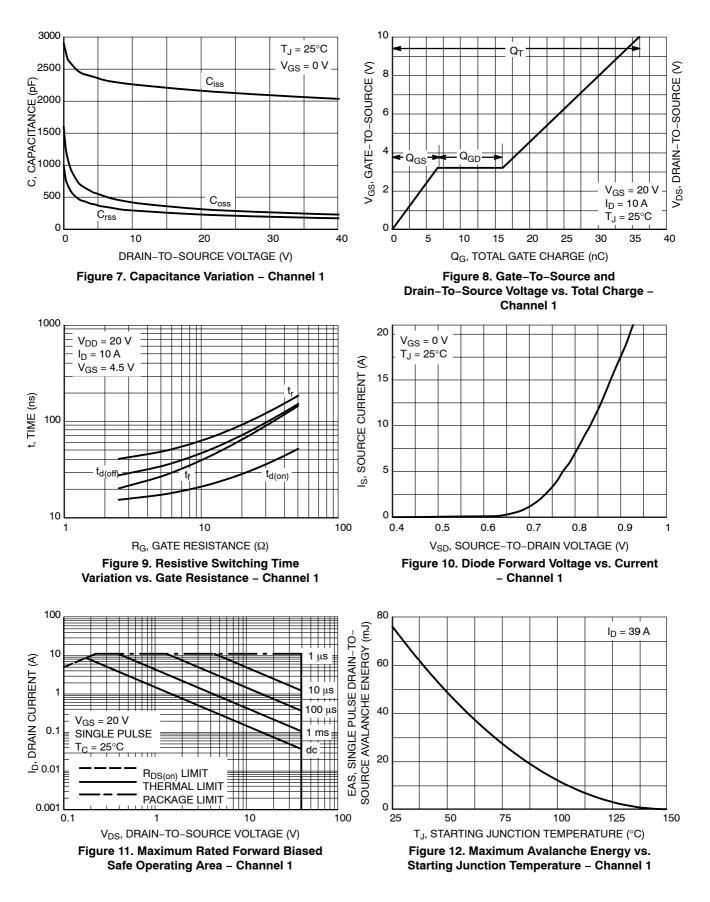
Turn-On Delay Time	t _{d(ON)}		Ch 1	16	ns
			Ch 2	11.5	1
Rise Time	tr		Ch 1	22	1
		V _{GS} = 4.5 V, V _{DD} = 20 V, CH1: I _D = 10 A, CH2: I _D = 7 A, R _G =	Ch 2	14	1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 10 \text{ A}, \text{ CH2: I}_D = 7 \text{ A}, \text{ H}_G = 2.5 \Omega$	Ch 1	26	
			Ch 2	15.5	
Fall Time	t _f		Ch 1	8.5	
			Ch 2	3.5	1

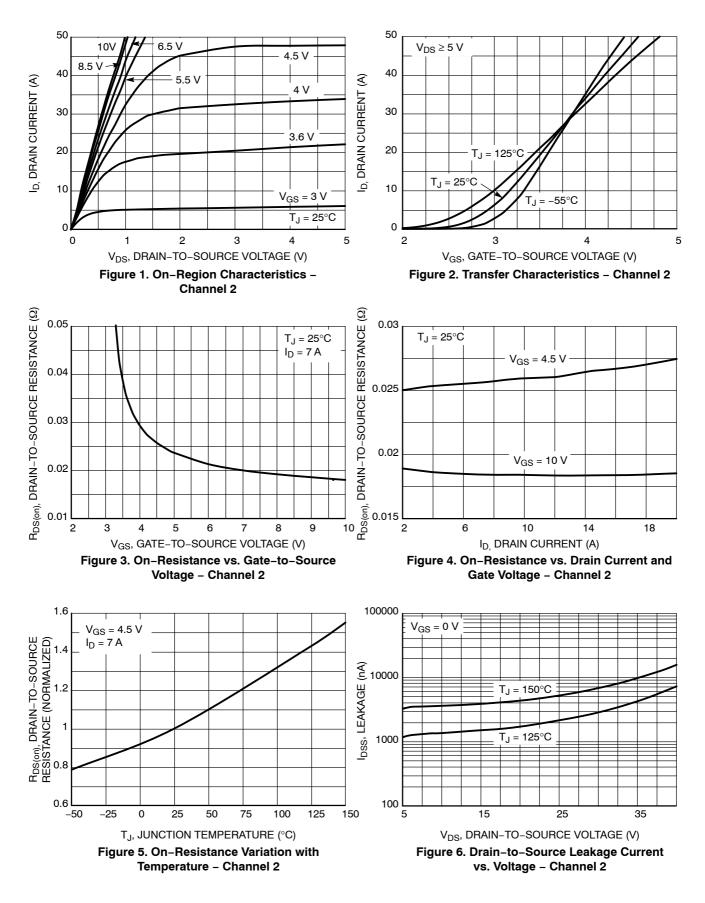
DRAIN-SOURCE DIODE CHARACTERISTICS

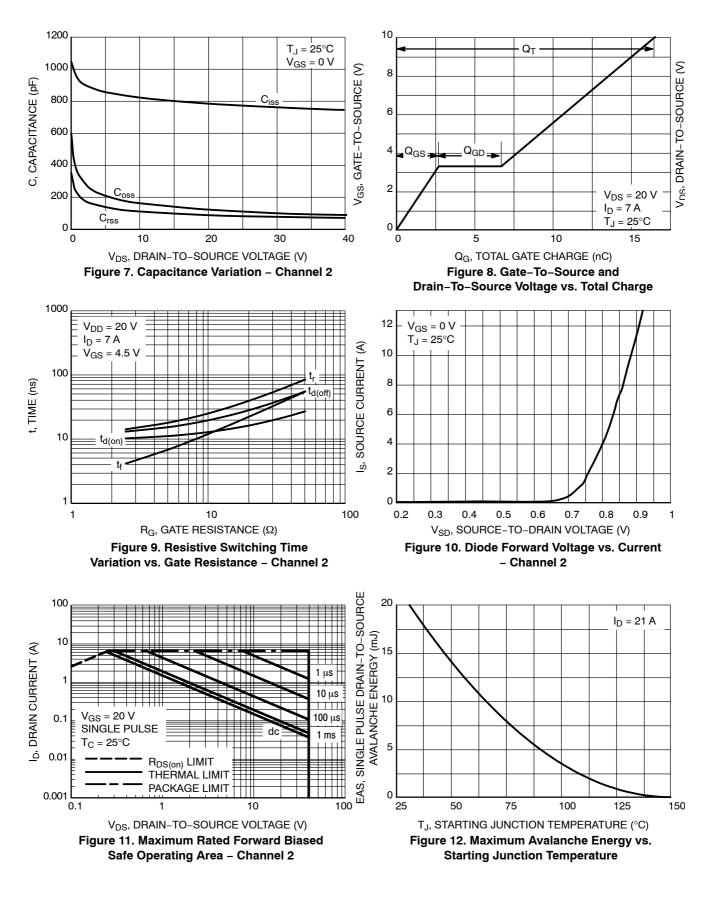
Forward Diode Voltage	V _{SD}		T. 25°C			0.9	1.2	V
		V _{GS} = 0 V, CH1: I _D =	$T_J = 25^{\circ}C$	Ch 2		0.85	1.2	
		10 A, CH2: I _D = 7 A	T 105%C	Ch 1		0.65		
		- / //	= 7 A $T_{\text{J}} = 125^{\circ}\text{C}$ C			0.73		
Reverse Recovery Time	t _{RR}		Ch 1		27		ns	
						17		
Charge Time	Ta			Ch 1		14		
		V _{GS} = 0 V, dISD	Ch 2		11			
Discharge Time	Т _b	CH1: I _D = 10 A,	Ch 1		13			
				Ch 2		6.0		
Reverse Recovery Charge	Q _{RR}		Ch 1		19		nC	
			Ch 2		9.0			

9. Pulse Test: pulse width \leq 300 μs , duty cycle \leq 2% 10. Switching characteristics are independent of operating junction temperatures









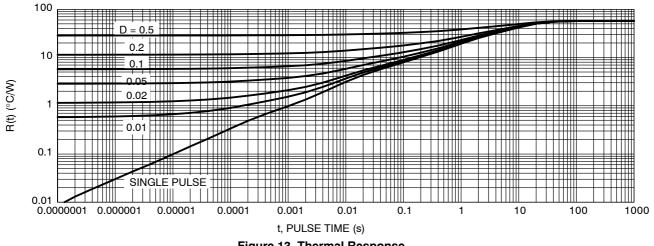
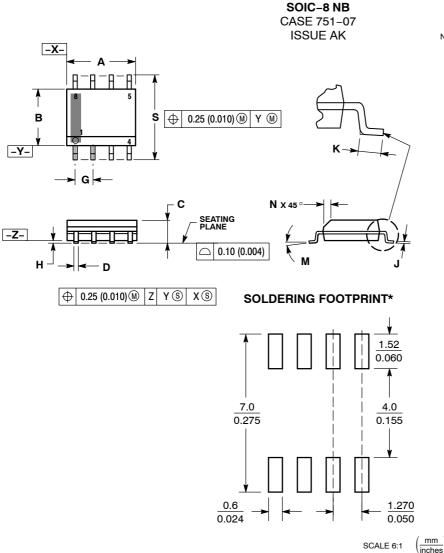


Figure 13. Thermal Response

PACKAGE DIMENSIONS



NOTES

1. DIMENSIONING AND TOLERANCING PER

- ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER. 2
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION. 3
- 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751–01 THRU 751–06 ARE OBSOLETE. NEW STANDARD IS 751–07. 6.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27	7 BSC	0.05	0 BSC
н	0.10	0.25	0.004	0.010
J	0.19	0.25	0.007	0.010
к	0.40	1.27	0.016	0.050
м	0 °	8 °	0 °	8 °
Ν	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SCALE 6:1

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